## Application/Control No. Applicant(s)/Patent Under Reexamination 09/833,609 WEIR ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Stephen J. Stein 1775 . **U.S. PATENT DOCUMENTS** Document Number Date Country Code-Number-Kind Code Name Classification MM-YYYY US-6,078,494 Α 06-2000 Hansen, Peter 361/321.5 US-В US-С US-D US-Ε F US-G US-US-Н US-US-J US-K US-L М US- FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν О Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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